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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

inventor:

Sreenivasan, Sidlqata V

App. No.:

10/805,916

GPAU:

2123

Filing Date:

March 22, 2004

Examiner:

Dkt. No.:

PA133-09D13

Conf. No.: 2031

For: Method of Determining Alignment of a Template and a

Substrate Having a Liquid Disposed Therebetween

INFORMATION DISCLOSURE STATEMENT

Mail Stop AMENDMENT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

The PTO did not receive the following listed Items(s) Some FIRs f MG

Sir:

The following information is submitted in compliance with Applicants' duty of disclosure and pursuant to 37 C.F.R. § 1.56, § 1.97 and § 1.98. The undersigned brings the patents, publications, applications or other information identified in the attached:

Form(s) PTO/SB/08A and/or PTO/SB/08B or PTO/1449

□ Other:

to the Examiner's attention in the above-identified application. It is respectfully requested that the cited information be expressly considered during the prosecution of this application, and the references be made of record therein and appear among the "references cited" on any patent to issue therefrom.

For the convenience of the Examiner, the references cited in the parent patent application number 09/907,512 are notated in attached forms PTO/SB/08A with bold font. Copies of these references are not required nor provided.

This Information Disclosure Statement is being filed:

before the mailing date of a first Office action on the merits or before the mailing date of a first Office action after the filing of a request for continued examination under § 1.114. Therefore, no fee is believed required.

Applicants do not believe that any additional fees are due, but if the Commissioner believes additional fees are due, the Commissioner is hereby authorized to charge any fees which may be required, or credit any overpayment, to Deposit Account Number 502650.

CERTIFICATE OF TRANSMISSION

I hereby certify that this correspondence is being facsimile transmitted to the USPTO or deposited with the United States Postal Service with sufficient postage as either First Class Mail or Express Mail, in an envelope addressed to the Commissioner for Patents.

Signed:_

Typed Name: Katrina Prati

Date.

4-6-05

Respectfully Submitted,

Kenneth C. Brooks, Reg. No. 38,393

Legal Department

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Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number ubstitute for form 1449A/PTO Complete if Known APPLICATION NUMBER 10/805,916 INFORMATION DISCLOSURE FILING DATE 03/22/2004 STATEMENT BY APPLICANT FIRST NAMED INVENTOR Sreenivasan et al. 2123 Group Art Unit (use as many sheets as necessary) Examiner Name Unassigned PA133-09D13 Attorney Docket Number Sheet

·				FOREIGN	PATENT DOCU	MENTS				
Examiner Initials*	Cite No.1 Office Number4 (if known)		Kind Code ⁵ Name of Patentee or Applicant of Cited I				f Publication of d Document I-DD-YYYY Passages or Relevant Figures Appear		T ⁶	
	B1	2002/0098426	A1	Sree	nivasan et al.	7/25/200	2			
	B2	4,731,155		Napo	oli et al.	3/15/198	8			
	B3	5,414,514		Smit	h et al.	5/9/1995				
	B4	5,425,848		Haisı	ma et al.	6/20/199	5			
	B5	5,772,905		Chou]	6/30/199	8			
	В6	5,808,742		Ever	ett et al.	9/15/199	8			
	B7	6,088,103		Ever	ett et al.	7/11/200	0			
<u> </u>	B8	6,309,580	B1	Chou	1	10/30/20	01			
	В9	6,334,960	B1	Wills	on et al.	1/1/2002				
	B10	6,391,217	B2	Scha	ffer et al.	5/21/200	2			
	B11	6,522,411	B1	Mooi	n et al.	2/18/200	3		44.	
	B12	6,696,220	B2	Baile	y et al.	2/24/200	4			
	B13	2002/0177319	A1	Chou	1	11/28/20	02			
	B14	6,713,238	B1	Chou	et al.	3/30/200	4			
	B15	2004/0008334	A1	Sree	nivasan et al.	1/15/200	4			
	B16	2004/0009673	A1	Sree	nivasan et al.	1/15/200	4			
	B17	2004/0124566	A1	Sreei	nivasan et al.	7/1/2004			· · · · · · · · · · · · · · · · · · ·	
	B18	3,783,520		King		1/8/1974			***	

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	ATEMENT			FILING DATE	03/22/2004		
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				Group Art Unit	2123		
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Sheet	2	of	8	Attorney Docket Number	PA133-09D13		

				FOREIGN	PATENT DOCUMENTS			
Examiner Initials*	Cite No.1	Office 3	Foreign Patent Doc Number ⁴	Kind Code ⁵ (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Ţ [€]

 B19	6,150,231		Muller et al.	11/21/2000	
B20	6,489,068	B1	Куе	12/3/2002	
B21	6,646,662	B1	Nebashi et al.	11/11/2003	
B22 .	6,776,094	B1	Whitesides et al.	8/17/2004	
B23	4,600,309		Fay	7/15/1986	
B24	4,848,911		Uchida et al.	7/18/1989	
B25	5,074,667		Miyatake	12/24/1991	
B26	5,148,036		Matsugu et al.	9/15/1992	
B27	5,148,037		Suda et al.	9/15/1992	
B28	6,518,189	B1	Chou	2/11/2003	
B29	2002/0132482	A1	Chou	9/19/2002	
B30	2002/0167117	A1	Chou	11/14/2002	
B31	6,482,742	B1	Chou	11/19/2002	
B32	2003/0080471	A1	Chou	5/1/2003	
B33	2004/0036201	A1	Chou et al.	2/26/2004	
B34	2004/0192041	A1	Jeong et al.	9/30/2004	
B35	6,828,244	B2	Chou	12/7/2004	
B36	6,809,356	B2	Chou	10/26/2004	

Examiner	Date	
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	ORMATION ATEMENT			FILING DATE	03/22/2004		
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				Group Art Unit	2123		
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Sheet	3	of	8	Attorney Docket Number	PA133-09D13		

				FOREIGN	PATENT DOCU	MENTS			
Examiner Initials*	Cite No.¹ Office Number⁴ Kind Code⁵ Site Number⁴ (if known) Name of Patentee or A			Date of Publication Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T _e			
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	B37	5,737,064		Inoue	e et al.	4/7/1998			
	B38	2004/0197843	A1	Chou	et al.	10/7/200	4		
	B39	2004/0156108	A1	Chou	et al.	8/12/200	4		
	B40	2004/0137734	A1	Chou	et al.	7/15/200	4		
	B41	2004/0131718	A1	Chou	et al.	7/8/2004			
	B42	2004/0118809	A1	Chou	et al.	6/24/200	4		
	B43	2004/0046288	A1	Chou		3/11/200	4		
	B44	2003/0080472	A1	Chou		5/1/2003			
	B45	2003/0034329	A1	Chou		2/20/200	3		
	B46	2002/0042027	A1	Chou	et al.	4/11/200	2		
	B47	6,636,311	B1	Ina e	t al.	10/21/20	03		
	B48	6,383,888	B1	Stirto	n	5/7/2002			
	B49	2004/0033515	A1	Cao e	et al.	2/19/200	4		
	B50	5,999,245		Suzu	ki	12/7/199	9		
	B51	6,630,410	B2	Trapp	et al.	10/7/200	3		
	B52	6,580,172	B2	Mano	ini et al.	6/17/200	3		
	B53	10/895,214		Voiso	n	7/20/200	4		
	B54	10/923,629		Sreer	nivasan et al.	8/20/200	4		

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Signature Considered	

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Substitute for form 1449A/PTO

Complete if Known

APPLICATION NUMBER 10/805,916

FILING DATE 03/22/2004

FIRST NAMED INVENTOR Screenivasan et al.

Group Art Unit 2123

[use as many sheets as necessary]

Examiner Name Unassigned

of

Attorney Docket Number

Sheet

				FOREIGN	PATENT DOCUM	MENTS				
Examiner Initials*	Cite No.1 Office Number4			Kind Code ⁵ Name of Patentee or (if known) Cited Docum					Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
	B55	10/978,285		Wills	on et al.	10/29/20	04			
	B56	11/000,321		Nimn	nakayala et al.	11/30/20	04			
	B57	4,512,848		Deck	man et al.	4/23/198	5			
	B58	6,388,755	B1	Zhao		5/14/200	2			
	B59	6,295,120	B1	Miya	take	9/25/200	1			
	B60	6,049,373		Miya	take	4/11/200	0			
	B61	6,285,439	B1	Miyat	Miyatake					
	B62	6,791,669	B2	Poon	Poon		4			
,,,	B63	6,517,995	B1	Jaco	benson et al.	2/11/200	3			
	B64	2004/0110856	A1	Youn	g et al.	6/10/200	4			
	B65	5,028,366		Hara	kal et al.	7/2/1991				
	B66	5,601,641		Stepl	nens	2/11/199	7			
	B67	5,849,209		Kindt	-Larsen et al.	12/15/19	98			
	B68	5,849,222		Jen e	et al.	12/15/19	98			

Examiner Date Signature Considered	
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			FORE	IGN PATENT DOCUMENTS			
Examiner Initials*	Cite No. ¹	Office 3	Foreign Patent Document Kind Code Number ⁴ (if known		Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T⁵
	B69	wo	00/21689	Chou et al.	4/20/2000		
	B70	JP	02-92603	Kurikawa et al.	4/3/1990		
	B71	JР	02-24848	Kamio	1/26/1990		
	B72	wo	01/47003	Steiner et al.	6/28/2001		
	B73	wo	02/07199	Chou	1/24/2002		
	B74	wo	2004/114016	Chou et al.	12/29/2004		
	B75	wo	99/05724	Chou et al.	2/4/1999		
	B76	wo	03/010289	Chou et al.	2/6/2003		
	B77	wo	03/079416	Chou	9/25/2003		
	B78	wo	03/099536	Chou et al.	12/4/2003		

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OTHER PRIC	OR ART -	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	B79	Chou, Nanoimprint Lithography and Lithographically Induced Self-Assembly, MRS Bulletin, pp. 512 - 517, 7/1/2001	•
	B80	Choi et al., Design of Orientation Stages for Step and Flash Imprint Lithography, Precision Engineering, pp. 192 - 199, 1/1/2001	
	B81	Colburn et al., Step and Flash Imprint Lithography for sub-100 nm Patterning, Proceedings of SPIE Vol. 3997, pp. 453 - 457, 1/1/2000	
	B82	Chou et al., Imprint Lithography with 25-Nanometer Resolution, Science Vol. 272, pp. 85 - 87, 4/5/1996	
	B83	Chou et al., Imprint Lithography with Sub-10 nm Feature Size and High Throughput, Microelectronic Engineering 35, pp. 237 - 240, 1/1/1997	
	B84	Haisma et al., Mold-assisted Nanolithography: A Process for Reliable Pattern Replication, J. Vac. Sci. Technol. B, pp 4124 - 4128, 11/1/1996	
	B85	Chou et al., Imprint of Sub-25 nm Vias and Trenches in Polymers, Appl. Phys. Lett. 67 (21), 11/20/1995	
	B86	Johnson et al., Advances in Step and Flash Imprint Lithography, SPIE Microlithography Conference, 2/23/2003	
	B87	Chou et al., Lithographically Induced Self-assembly of Periodic Polymer Micropillar Arrays, J. Vac. Sci. Technol. B 17 (6), pp. 3197 - 3202, 11/1/1999	

Examiner Signature	Date Considered	

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INFO	RMATION	DISCLO	SURE	APPLICATION NUMBER	10/805,916	
STA	TEMENT B	Y APPL	ICANT	FILING DATE	03/22/2004	
				FIRST NAMED INVENTOR	Sreenivasan et al.	
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	. .			Attorney Docket Number	PA133-09D13	

OTHER PRI	OR ART	- NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	B88	Colburn et al., Step and Flash Imprint Lithography: A New Approach to High-Resolution Patterning, Proc. Of SPIE, vol. 3676, 3/1/1999	
	B89	Heidari, Nanoimprint Lithography at the 6 in. Wafer Scale, J. Vac. Sci. Technol. B 18(6), pp. 3557 - 3560, 11/1/2000	
	B90	Translation of Japanese Patent 02-92603	
	B91	Translation of Japanese Patent 02-24848	
	B92	Chou et al., Ultrafast and Direct Imprint of Nanostructures in Silicon, Nature, Col. 417, (June 2002), pp. 835-837, 6/1/2002	
,	B93	Moon et al., Interferometric-Spatial-Phase Imaging for Six-Axis Mask Control, MIT NanoStructures Laboratory, Research Laboraty of Electronics, 10/17/2003	
	B94	Chou et al., Nanoimprint Lithography, Journal of Vacuum Science Technolgoy B 14(16), pp. 4129-4133, 11/1/1996	
	B95	Colburn et al., Development and Advantages of Step-and-Flash Lithography, Solid State Technology, 7/1/2001	
	B96	Colburn et al., Characterization and Modeling of Volumetric and Mechanical Properties for Step and Flash Imprint Lithography Photopolymers, Journal of Vacuum Science Technology. Vol b.	

Examiner Signature	Date Considered	

19(6), 11/1/2001

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INFO	RMATION	DISCLO	SURE	APPLICATION NUMBER	10/805,916	
STAT	EMENT B	Y APPLI	CANT	FILING DATE	03/22/2004	
				FIRST NAMED INVENTOR	Sreenivasan et al.	
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Sheet	8	of	8	Examiner Name	Unassigned	
				Attorney Docket Number	PA133-09D13	

OTHER PRIOR	R ART -	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	B97	Bailey et al., Step and Flash Imprint Lithography: Defect Analysis, Journal of Vacuum Science, B 19(6), pp. 2806-2810, 11/1/2001	
	B98	Bailey et al., Step and Flash Imprint Lithography: Template Surface Treatment and Defect Analysis, Journal of Vacuum Science, B 18(6), pp. 3572-3577, 11/1/2000	
	B99	Wronosky et al., Wafer and Reticle Positioning System for the Extreme Ultraviolet Lithography Engineering Test Stand, Emerging Lithography Technologies, Proceedings of SPIE Vol. 3997, pp. 829-839, 7/1/2000	
	B100	Schneider et al., Stripes of Partially Fluorinated Alkyl Chains: Dipolar Langmuir Monolayers	
	L	•	
Examiner Signature		Date Considered	

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